


<b>Search Notes</b>  	<b>Application/Control No.</b>  10587281	<b>Applicant(s)/Patent Under Reexamination</b>  HAYASHI ET AL.
	<b>Examiner</b>  Hai Vo	<b>Art Unit</b>  1794

SEARCHED			
Class	Subclass	Date	Examiner
428	304.4, 131, 319.1, and 901	10/22/2007	HV
Above to date		6/19/2008	HV

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name search	10/22/2007	HV
Text search	10/22/2007	HV
Reviewed IDS	10/22/2007	HV
JP 2002-317089	6/19/2008	HV
Text search	1/1/2009	HV

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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